

<b>Notice of References Cited</b>	Application/Control No. 10/573,099		Applicant(s)/Patent Under Reexamination LIU, LAISHENG	
	Examiner DAVID EASTWOOD		Art Unit 4185	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,501,836 A	03-1970	MORET MICHEL A; et. al.	30/43.92
*	B	US-3,673,671 A	07-1972	Petersen, George R.	29/432.2
*	C	US-5,100,414 A	03-1992	Dolev, Moshe	606/133
*	D	US-5,108,410 A	04-1992	Iwasaki et al.	606/133
*	E	US-5,234,442 A	08-1993	Schafer et al.	606/133
*	F	US-5,356,415 A	10-1994	Iwasaki et al.	606/133
*	G	US-6,436,106 B2	08-2002	Yiu, Wai-Wah	606/133
*	H	US-6,123,713	09-2000	Yiu et al.	606/133
*	I	US-5,976,157	11-1999	Yiu, Wai-Wah	606/133
*	J	US-5,810,843	09-1998	Iwasaki et al.	606/133
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	X				

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